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UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address of MARISSIP CHEECE PACENTS AND TRADEMARKS was displayed and the Commercial Com

APPLICATION NO	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
09 895,333	07 02 2001	Ofer Du-Nour	01 21786	6693
75	90 11 05 2002			
G.E. EHRLICH (1995) LTD. e o ANTHONY CASTORINA SUITE 207 2001 JEFFERSON DAVIS HIGHWAY ARLINGTON, VA. 22202			EXAMINER	
			VANORE, DAVID A	
			ART UNIT	PAPER NUMBER
. Melindron,	7.1 222V2		2881	

DATE MAILED: 11-05-2002

Please find below and/or attached an Office communication concerning this application or proceeding.

•		Application No.	Applicant(s)			
	•	. 09/895.333	DU-NOUR, OFER			
Office Action Summary		Examiner	Art Unit			
		David A Vanore	2881			
	The MAILING DATE of this communication a	ppears on the cover sheet	with the correspondence address			
Period fo	• •		MONTH(S) EDOM			
THE - Exte after - If the - If NC - Failu - Any	ORTENED STATUTORY PERIOD FOR REF MAILING DATE OF THIS COMMUNICATION naions of time may be available under the provisions of 37 CFR SIX (6) MONTHS from the mailing date of this communication. It is period for reply specified above is less than thirty (30) days, a report of the period for reply is specified above, the maximum statutory perion to reply within the set or extended period for reply will, by state reply received by the Office later than three months after the mailed patent term adjustment. See 37 CFR 1.704(b).	N. 1.136(a). In no event, however, may eply within the statutory minimum of to od will apply and will expire SIX (6) Mo tute. cause the application to become	a reply be timely filed nirty (30) days will be considered timely. DNTHS from the mailing date of this communication. ABANDONED (35 U.S.C. § 133).			
1)	Responsive to communication(s) filed on _	·				
2a) <u></u>	This action is FINAL 2b)⊠	This action is non-final.				
3)	Since this application is in condition for allo closed in accordance with the practice und	owance except for formal m er <i>Ex parte Quayle</i> , 1935 (natters, prosecution as to the merits is D.D. 11, 453 O.G. 213.			
-	ion of Claims					
4)⊡	Claim(s) <u>1-40</u> is/are pending in the applicat					
	4a) Of the above claim(s) is/are withdrawn from consideration.					
	Claim(s) is/are allowed.					
	Claim(s) <u>1-40</u> is/are rejected.					
	Claim(s) is/are objected to.					
	Claim(s) are subject to restriction and ion Papers	d/or election requirement.				
• •	The specification is objected to by the Exami	ner				
· —	The drawing(s) filed on 27 September 2001		l objected to by the Examiner.			
10)[_]	Applicant may not request that any objection to					
11)	The proposed drawing correction filed on					
,	If approved, corrected drawings are required in					
12)	The oath or declaration is objected to by the	Examiner.				
Priority	under 35 U.S.C. §§ 119 and 120					
13)	Acknowledgment is made of a claim for fore	eign priority under 35 U.S.C	c. § 119(a)-(d) or (f).			
a)	☐ All b)☐ Some * c)☐ None of:					
	1. Certified copies of the priority docume	ents have been received.				
	2. Certified copies of the priority docume	ents have been received in	Application No			
* ;	 Copies of the certified copies of the p application from the International See the attached detailed Office action for a 	Bureau (PCT Rule 17.2(a)).			
14) 🔲 /	Acknowledgment is made of a claim for dome	estic priority under 35 U.S.	C. § 119(e) (to a provisional application).			
15) <u> </u>	a) The translation of the foreign language Acknowledgment is made of a claim for dom	provisional application has estic priority under 35 U.S.	been received. C. §§ 120 and/or 121.			
Attachmer	nt(s)					
2) Notice	ce of References Cited (PTO-892) ce of Draftsperson's Patent Drawing Review (PTO-948) rmation Disclosure Statement(s) (PTO-1449) Paper No(s	5) Notice	ow Summary (PTO-413) Paper No(s) of Informal Patent Application (PTO-152)			
S. Patent and	Tragemark Office					

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Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-10, 12-18, 20-26, and 28-39 are rejected under 35 U.S.C. 102(b) as being clearly anticipated by Akiyama et al.

Akiyama et al. teaches the following:

- 1) A production line and associated device in a production line for producing a multilayer semiconductor wafer product comprising a predetermined reflected light intensity spectra (Col. 3 Line 61 Col. 4 Line 6), a means to detect reflected light intensity spectra (Col. 3 Line 61 Col. 4 Line 6), and a comparator (Col. 3 Line 61 Col. 4 Line 6) which are contained in spectrometer 17 (Note Fig. 6) and processing unit 18 as recited in claims 1, 12, 15, 20, 23, 28, 29, 30, and 36.
- 2) A routing error indicator and a mechanism for interrupting the production of a sample are inherent in the teaching of Akiyama et al. Akiyama et al. teaches that after comparing the detected spectral reflectance and the predetermined spectral reflectance, the processing means makes a decision to stop and alter production parameters, or to continue. This decision and interruption are the same as the routing error indicator and interruption mechanism because the function of the device of Akiyama et al. and the claimed limitation are the same as recited in claims 2, 3, 13, 14, 31, and 32.

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- 3) A plurality of production tools operating in parallel (Col. 9 Lines 14-41) as recited in claims 4, 21, and 33.
- 4) Each stage having a spectrum comparing means. Akiyama et al. teaches a device having multiple film forming stages and that the thickness of each film is measured based on the reflected spectra and compared to a predetermined spectra at each film forming stage (Col. 2 Line 66-Col. 3 Line 5) followed by an adjustment and rerouting of the production processes as determined by the comparison of spectral data (Fig. 1) as recited in claims 5, 6, 7, 22, 34, and 35.
- 5) An intensity spectrum deriving means which inherently comprises an illumination means, a reflected radiation detector, an analyzer for determining a frequency spectrum of reflected intensities, and a layer property determining means. The device of Akiyama et al. utilizes an optical spectrometer which irradiates a plurality of wavelengths (Fig. 6) and must have an illumination means, a detector, and analysis means, to determine layer thickness and optical properties including reflection and multiple interference effects (Col. 9 Lines 5-11) of a multilayer wafer as recited in claims 8, 9, 10, 16, 17, 18, 24, 25, 26, 37, 38, and 39.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.



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Claims 11, 19, 27, and 40 rejected under 35 U.S.C. 103(a) as being unpatentable over Akiyama et al.

Akiyama et al. teaches all limitations as recited above, but fails to teach the analysis of frequency spectra using Fourier transforms.

Fourier transforms are one of a plurality of mathematical methods for the analysis of detected signals.

It would have been obvious to one having ordinary skill in the art at the time the invention was made to select Fourier transforms as a tool for the analysis of frequency spectra because the use of Fourier transforms to analyze spectral data is well known in the art.

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

The following prior art references teach spectral analysis of semiconductor wafers and are considered to at least be relevant as background art to the present application:

US Patent 4,623,254 (Imose), US Patent 5,757,502 (Weling),

US Patent 4,785,336 (McComb et al.)

Any inquiry concerning this communication or earlier communications from the examiner should be directed to David A Vanore whose telephone number is 703-306-0246. The examiner can normally be reached on M-F 7:30-5:00.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Lee can be reached on 703-308-4116. The fax phone numbers for the organization where this application or proceeding is assigned are 703-308-7722 for regular communications and 703-308-7721 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

dav October 22, 2002

SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800